Special Issue

Feature Review Papers in Fault Diagnosis & Sensors

Message from the Guest Editors

This Special Issue is a dedicated collection of comprehensive review papers that aims to bring together the latest advancements and insights in fault diagnosis for condition monitoring, structural health monitoring, non-destructive testing and sensor technologies. Potential topics include, but not limited to, the following:

- Fault detection and diagnosis;
- Fault/failure prognosis;
- Structural health monitoring;
- Non-destructive testing (NDT);
- Condition monitoring;
- Digital twins for fault diagnosis;
- Artificial intelligence for fault diagnosis.

To be a significant resource for the scientific community, this Special Issue provides a platform for the dissemination of the current state of the art and novel perspectives in the field. We look forward to receiving your contributions and making this a successful and impactful Special Issue.

Guest Editors

Prof. Dr. Len Gelman

Prof. Dr. Gilbert-Rainer Gillich

Prof. Dr. Shuncong Zhong

Deadline for manuscript submissions

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Message from the Editor-in-Chief

Sensors is a leading journal devoted to fast publication of the latest achievements of technological developments and scientific research in the huge area of physical, chemical and biochemical sensors, including remote sensing and sensor networks. Both experimental and theoretical papers are published, including all aspects of sensor design, technology, proof of concept and application. Sensors organizes Special Issues devoted to specific sensing areas and applications each year.

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